

BOARD OF PATENT APPEALS AND INTERFERENCES CONFERENCE

Chief Judge Michael R. Fleming
and
The Board of Patent Appeals and Interferences

are proud to announce the

FIRST ANNUAL BOARD CONFERENCE

Special Guest Luncheon Speaker

David Kappos
Under Secretary of Commerce for Intellectual Property and
Director of the U.S. Patent and Trademark Office

Through a series of presentations and panels, participants will increase their knowledge of: the decision-making process at the Board; how to avoid mistakes commonly made when appearing before the Board; how to properly and persuasively present evidence by way of affidavits; and the inter partes reexamination process. Participants will also hear from Chief Judge Paul R. Michel and Circuit Judge Randall R. Rader of the U.S. Court of Appeals for the Federal Circuit on the role of the Board in the development and advancement of the patent system.

Speakers include:

The Honorable Paul R. Michel, Chief Judge for the U.S. Court of Appeals for the Federal Circuit
The Honorable Randall R. Rader, Circuit Judge for the U.S. Court of Appeals for the Federal Circuit
Michael R. Fleming, Chief Judge of the BPAI
James T. Moore, Vice Chief Judge of the BPAI
Allen R. MacDonald, Vice Chief Judge of the BPAI
Gregory Morse, USPTO Central Reexam Unit
Todd Baker, Oblon, Spivak, McClelland, Maier & Neustadt, L.L.P.
Gary Harkcom, Greenblum & Bernstein, P.L.C.
Stephen Kunin, Oblon, Spivak, McClelland, Maier & Neustadt, L.L.P.
Michael Messinger, Sterne, Kessler, Goldstein & Fox P.L.L.C.
Brad Pedersen, Patterson, Thuente, Skaar & Christensen, P.A.
Teresa Rea, Crowell & Moring LLP
Charles Van Horn, Finnegan, Henderson, Farabow, Garrett & Dunner LLP

Registration \$100 (Includes continental breakfast, box lunch, and afternoon refreshments)

For further information and/or to register go to <http://conferences.thehillgroup.com/USPTO/BPAIconference/index.html>



Wednesday, April 7, 2010

Madison Auditorium | United States Patent and Trademark Office
600 Dulany Street, Alexandria, Virginia